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| Notice of References Cited | Application/Control No. 09/747,871 | Applicant(s)/Patent Under Reexamination DAVIS ET AL. | |
| | Examiner Thu V Huynh | Art Unit 2178 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-5,855,015 | 12-1998 | Shoham, Yoav | 707/5 |
| | B | US-5,553,216 | 09-1996 | Yoshioka et al. | 715/515 |
| | C | US-6,108,698 | 08-2000 | Tenev et al. | 709/220 |
| | D | US-6,049,799 | 04-2000 | Mangat et al. | 707/10 |
| | E | US-6,073,135 | 06-2000 | Broder et al. | 707/100 |
| | F | US-6,509,898 | 01-2003 | Chi et al. | 345/440 |
| | G | US-6,321,242 | 11-2001 | Fogg et al. | 715/513 |
| | H | US-6,021,435 | 02-2000 | Nielsen, Jakob | 709/224 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

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